

## IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT (IECEE) CB SCHEME

## **CB TEST CERTIFICATE**

**Product** 

Name and address of the applicant

Name and address of the manufacturer

Name and address of the factory

Note: When more than one factory, please report on page 2

LED driver

Signify Netherlands B.V.

High Tech Campus 48, 5656 AE Eindhoven

The Netherlands

Signify Netherlands B.V.

High Tech Campus 48, 5656 AE Eindhoven

The Netherlands

Additional information on page 2

Ratings and principal characteristics

XITANIUM 20W/m 0.15-0.5A 52V 230V

Uin: 220-240 Vac; 186-250 Vdc; Freq: 50/60 Hz; DC; Iin: 0,12 Aac,

0,13-0,09 Adc; PF: 0,9C; Pin: 24W;

lout: 0,5 Adc; Pout: 20 W; U-out: 60 Vdc max; tc: 80 °C; ta: -20...+50 °C; Built-in; Independent (with SR caps);

XITANIUM 36W/m 0.3-1.05A 52V 230V

Uin: 220-240 Vac; 186-250 Vdc; Freq: 50/60 Hz; DC; Iin: 0,2 Aac,

0,23-0,16 Adc; PF: 0,9C; Pin: 42W;

Iout: 1,05 Adc; Pout: 36 W; U-out: 60 Vdc max; tc: 80 °C; ta: -20...+50 °C; Built-in; Independent (with SR caps);

XITANIUM 43W/m 0.7-1.2A 52V 230V

Uin: 220-240 Vac; 186-250 Vdc; Freq: 50/60 Hz; DC; Iin: 0,23 Aac,

0,27-0,19 Adc; PF: 0,9C; Pin: 50W;

lout: 1,2 Adc; Pout: 43 W; U-out: 60 Vdc max; tc: 90 °C; ta: -20...+45 °C; Built-in; Independent (with SR caps);

Trademark (if any) **PHILIPS** 

Customer's Testing Facility (CTF) Stage used

Model / Type Ref.

Date: 2021-10-21

Additional information (if necessary may also be reported on page 2)

CTF Stage 3

XITANIUM 20W/m 0.15-0.5A 52V 230V XITANIUM 36W/m 0.3-1.05A 52V 230V XITANIUM 43W/m 0.7-1.2A 52V 230V

Additional information on page 2

This CB Test Certificate is issued by the National Certification Body

DEKRA Certification B.V. Meander 1051, NL-6825 MJ Arnhem, Netherlands





## IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT (IECEE) CB SCHEME

A sample of the product was tested and found to be in conformity with

IEC 60598-1:2014, IEC 60598-1:2014/AMD1:2017, IEC 61347-1:2015, IEC 61347-1:2015/AMD1:2017, IEC 61347-2-13:2014, IEC 61347-2-13:2014/AMD1:2016, IEC 62384:2006, IEC 62384:2006/AMD1:2009

National differences:

**EU Group Differences** 

As shown in the Test Report Ref. No. which forms part of this Certificate

6113950.50 and 6113950.51

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Date: 2021-10-21





IEC SYSTEM FOR MUT	UAL RECOGNITION (	OF TEST CEF	RTIFICATES FOR	ELECTRICAL	<b>EQUIPMENT</b>
(IECEE) CB SCHEME					

Additional factory

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Date: 2021-10-21



Signature: Kate Xu